Sear	ch	Not	tes	
11: 11:11:11:1	91 11918	11111 <b>11</b>	188 (1881)	I

Search Notes			
1111111111111			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/716,037	BANTZ ET AL.
Examiner	Art Unit
Benjamin E. Lanier	2132

SEARCHED			
	SEARCHED		
Class	Subclass	Date	Examiner
713	155	6/18/2007	H
713	162 ·	6/18/2007	K
	•		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		·	
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated Search of 726/22-25 713/188	6/19/2007	H
EIC Fast & Focused Search See Attachment	6/20/2007	i.
Inventor Name Search Palm .	6/20/2007	H
Interference Search See Attachment	6/20/2007	E.